

• General Description

The AGM628MD combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

This device is ideal for load switch and battery protection applications.

Features

- Advance high cell density Trench technology
- Low R_{DS(ON)} to minimize conductive loss
- ■Low Gate Charge for fast switching
- ■Low Thermal resistance
- ■100% Avalanche tested
- ■100% DVDS tested

Application

- ■MB/VGA Vcore
- ■SMPS 2nd Synchronous Rectifier
- ■POL application
- ■BLDC Motor driver

Product Summary

BVDSS	RDSON	ID
60V	28mΩ	30A
-60V	41mΩ	-25A

TO-252-4L Pin Configuration



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
AGM628MD	AGM628MD	TO-252-4L	330mm	16mm	2500

Table 1. Absolute Maximum Ratings (TA=25°C)

		Rating		
Symbol	Parameter	N-Ch	P-Ch	Units
V _{DS}	Drain-Source Voltage (V _{GS} =0V)	60	-60	V
V _{GS}	Gate-Source Voltage (V _{DS=} 0V)	±20	±20	V
	Drain Current-Continuous(Tc=25℃) (Note 1)	30	-25	А
I _D	Drain Current-Continuous(Tc=100°C)	16	-12	А
IDM (pluse)	Drain Current-Pulsed (Note 2)	120	-100	А
	Total Power Dissipation(Tc=25℃)	35	35	W
P₀	Total Power Dissipation(Tc=100°C)	13.8	13.8	W
EAS	Avalanche energy (Note 3)	49	72	mJ
TJ,TSTG	Operating Junction and Storage Temperature Range	-55 To 150	-55 To 150	°C

Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
ReJA	Thermal Resistance Junction-ambient (Steady State) ¹		62	°C/W
Rejc	Thermal Resistance Junction-Case ¹		3.6	°C/W



Table 3. N- Channel Electrical Characteristics (TJ=25℃unless otherwisenoted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off State	es					
BVDSS	Drain-Source Breakdown Voltage	VGS=0V ID=250µA	60			V
IDSS	Zero Gate Voltage Drain Current	VDS=60V,VGS=0V			1	μA
IGSS	Gate-Body Leakage Current	VGS=±20V,VDS=0V			±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS,ID=250µA	1.2	1.5	2.2	V
gFS	Forward Transconductance	VDS=5V,ID=10A		15		S
RDS(on)	Drain-Source On-State Resistance	VGS=10V, ID=15A		28	34	mΩ
T D O (OII)	Brain Godrec on Glate Registance	VGS=4.5V, ID=10A		35	50	mΩ
Dynamic C	Characteristics					
Ciss	Input Capacitance			856		pF
Coss	Output Capacitance	VDS=30V,VGS=0V,		55		pF
Crss	Reverse Transfer Capacitance	F=1MHZ		47		pF
Rg	Gate resistance	VGS=0V, VDS=0V,f=1.0MHz		1.4		Ω
Switching	Times					
td(on)	Turn-on Delay Time			4.5		nS
tr	Turn-on Rise Time	VGS=10V,VDS=30V,		18		nS
td(off)	Turn-Off Delay Time	RL= 2.5Ω ,RGEN= 3Ω		14.5		nS
tf	Turn-Off Fall Time			18		nS
Qg	Total Gate Charge			19		nC
Qgs	Gate-Source Charge	VGS=10V, VDS=30V, ID=3A		4.2		nC
Qgd	Gate-Drain Charge	_ ID-0A		2.5		nC
Source-Drain Diode Characteristics						
ISD	Source-Drain Current(Body Diode)				30	Α
VSD	Forward on Voltage	VGS=0V,IS=15A		0.8	1.2	V
trr	Reverse Recovery Time	IF=15A , dI/dt=100A/μs ,				ns
Qrr	Reverse Recovery Charge	TJ=25℃				nc

Notes 1.The maximum current rating is package limited.

Notes 2.Repetitive Rating: Pulse width limited by maximum junction temperature

Notes 3.EAS condition: TJ=25 $^{\circ}$ C,VDD=30V,Vgs=10V,ID=14A, L=0.5mH,RG=25ohm



Table 3. P-Channel Electrical Characteristics (TJ=25℃unless otherwisenoted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off States						
BVDSS	Drain-Source Breakdown Voltage	VGS=0V ID=-250µA	-60			V
IDSS	Zero Gate Voltage Drain Current	VDS=-60V,VGS=0V			-1	μA
IGSS	Gate-Body Leakage Current	VGS=±20V,VDS=0V			±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS,ID=-250µA	-1.2	-1.7	-2.2	V
gFS	Forward Transconductance	VDS=-5V,ID=-10A		14		S
RDS(on)	Drain-Source On-State Resistance	VGS=-10V, ID=-15A		41	67	mΩ
1.20(011)	Brain Course on State Hosiotanes	VGS=-4.5V, ID=-10A		52	88	mΩ
Dynamic C	Characteristics					
Ciss	Input Capacitance	VDS=-30V,VGS=0V,		770		pF
Coss	Output Capacitance	F=1MHZ		112		pF
Crss	Reverse Transfer Capacitance			9.0		pF
Rg	Gate resistance	VGS=0V, VDS=0V,f=1.0MHz		4.2		Ω
Switching	Times					
td(on)	Turn-on Delay Time			10		nS
tr	Turn-on Rise Time	VGS=-10V,VDS=-30V,		6.0		nS
td(off)	Turn-Off Delay Time	RGEN=3Ω		40		nS
tf	Turn-Off Fall Time			13		nS
Qg	Total Gate Charge			25		nC
Qgs	Gate-Source Charge	VGS=-10V, VDS=-30V, ID=-3A		5.8		nC
Qgd	Gate-Drain Charge	_ VDO=-00V, ID=-0/A		3.1		nC
Source-Drain Diode Characteristics						
ISD	Source-Drain Current(Body Diode)				-25	А
VSD	Forward on Voltage	VGS=0V,IS=-15A		-0.8	-1.2	V
trr	Reverse Recovery Time	IF=-15A , dl/dt=100A/μs ,				ns
Qrr	Reverse Recovery Charge	TJ=25℃				nc

Notes 1. The maximum current rating is package limited.

Notes 2. Repetitive Rating: Pulse width limited by maximum junction temperature Notes

3.EAS condition: TJ=25 $^{\circ}\text{C}$,VDD=-30V,Vgs=-10V,ID=-17A, L=0.5mH,RG=25ohm



N-Channel Typical Characteristics

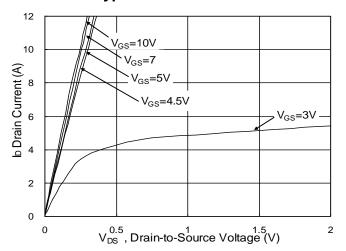


Fig.1 Typical Output Characteristics

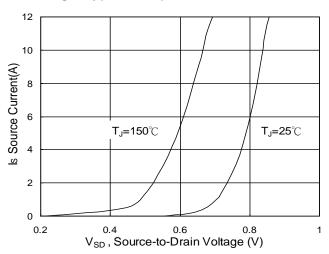


Fig.3 Forward Characteristics of Reverse

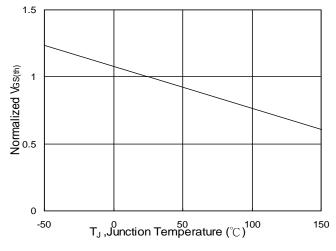


Fig.5 Normalized V_{GS(th)} v.s T_J

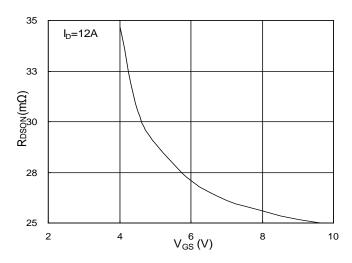


Fig.2 On-Resistance v.s Gate-Source

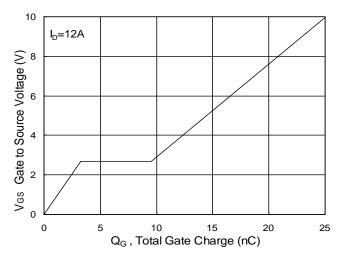


Fig.4 Gate-Charge Characteristics

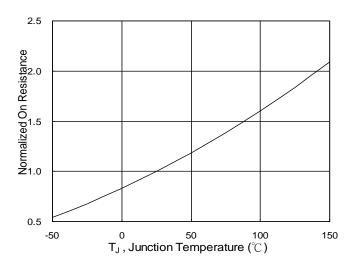
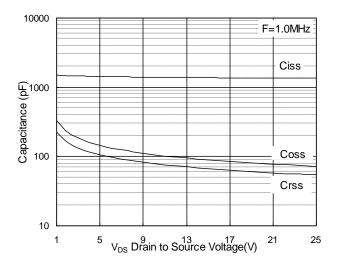


Fig.6 Normalized R_{DSON} v.s T_J





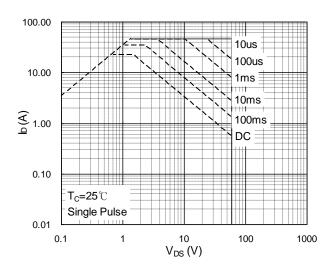


Fig.7 Capacitance

Fig.8 Safe Operating Area

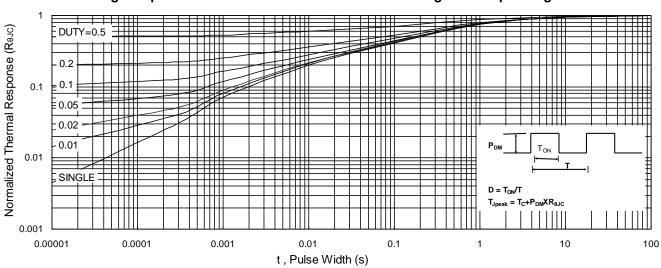


Fig.9 Normalized Maximum Transient Thermal Impedance

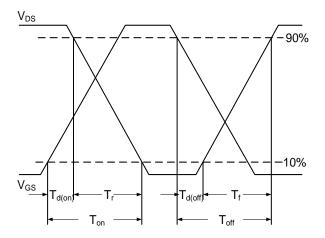


Fig.10 Switching Time Waveform

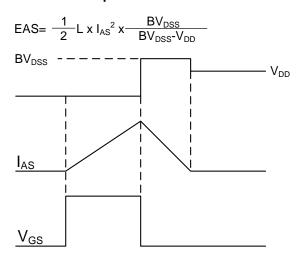


Fig.11 Unclamped Inductive Waveform



P-Channel Typical Characteristics

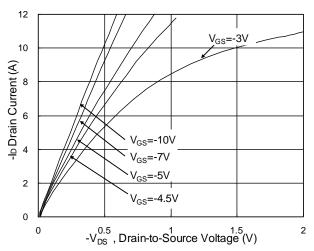


Fig.1 Typical Output Characteristics

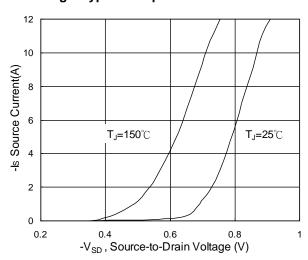


Fig.3 Forward Characteristics of Reverse

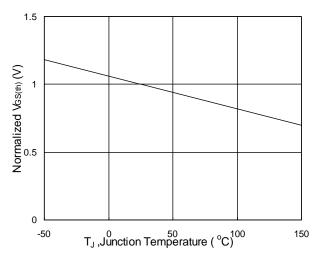


Fig.5 Normalized V_{GS(th)} v.s T_J

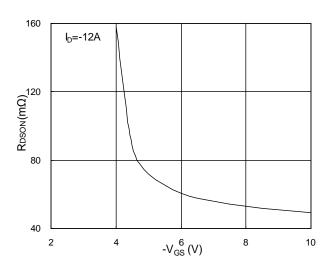


Fig.2 On-Resistance v.s Gate-Source

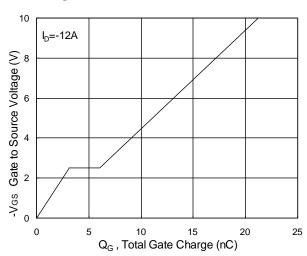


Fig.4 Gate-Charge Characteristics

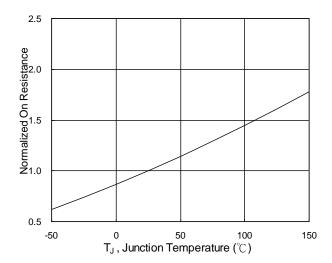
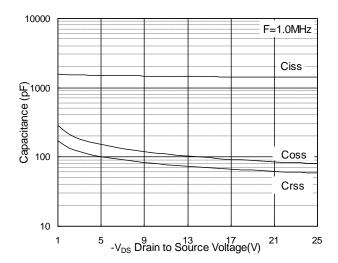


Fig.6 Normalized R_{DSON} v.s T_J



P-Channel Typical Characteristics



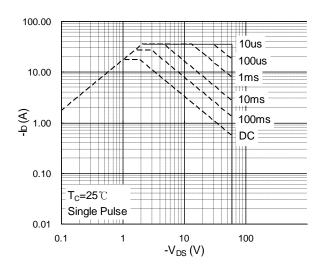


Fig.7 Capacitance

Fig.8 Safe Operating Area

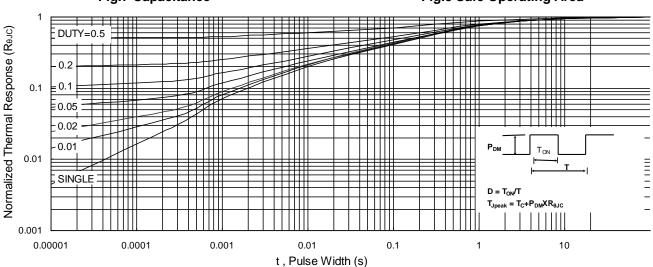


Fig.9 Normalized Maximum Transient Thermal Impedance

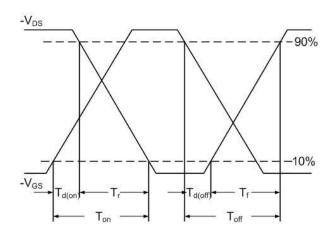


Fig.10 Switching Time Waveform

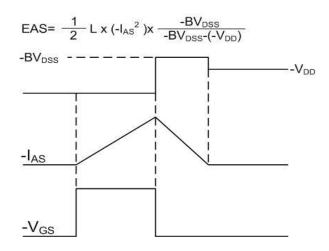
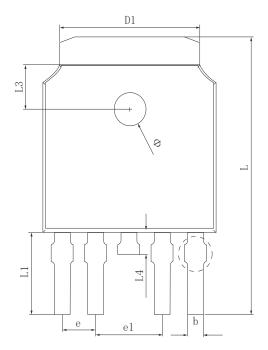
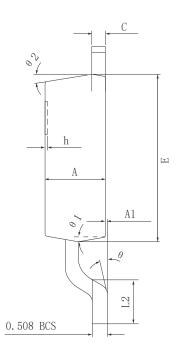


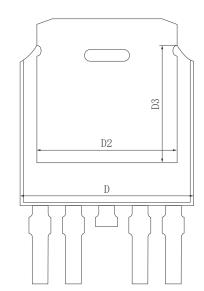
Fig.11 Unclamped Inductive Waveform

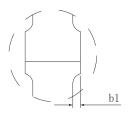


•Dimensions (TO-252-4L)





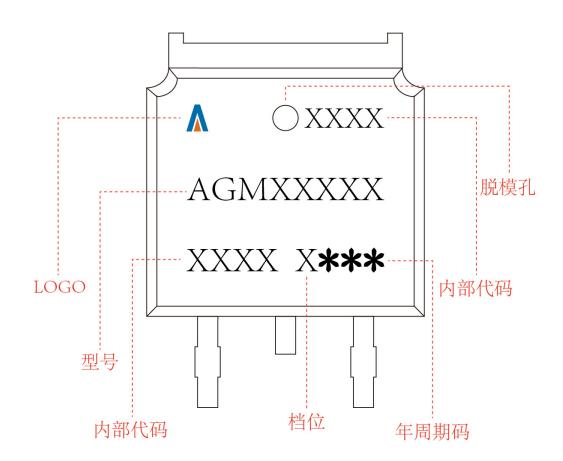




avamo.	MILLIMETER				
SYMBOL	MIN	Тур.	MAX		
A	2. 200	2. 300.	2. 400		
A1	0.000		0. 127		
b	0.550	0.600	0. 650		
b1	0.000		0. 120		
c(电镀后)	0.460	0.520	0. 580		
D	6. 500	6.600	6. 700		
D1		5.334 REF			
D2		5.346 REF			
D3		4.490 REF			
Е	6.000	6. 100	6. 200		
е	1.270 TYP				
e1	2. 540 TYP				
h	0.000	0.100	0. 200		
L	9. 900	10. 100	10.300		
L1		2.988 REF			
L2	1. 400 1. 550 1. 700				
L3	1.600 REF				
L4	0.700	0.700 0.800 0.900			
Ф	1.100	1.200	1. 300		
θ	0°		8°		
θ 1	9° TYP				
θ2	9° TYP				



TO-252-4L Marking Instructions:





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